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A04404B

30V N-Channel MOSFET

General Description

The AO4404B uses advanced trench technology to provide excellent $R_{\rm DS(ON)},$ low gate charge and operation with gate voltages as low as 2.5V. This device makes an excellent high side switch for notebook CPU core DC-DC conversion.

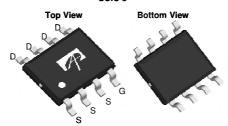
Product Summary

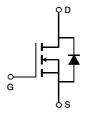
 $\begin{array}{lll} V_{DS} & 30V \\ I_{D} & (at \ V_{GS} \! = \! 10V) & 8.5A \\ R_{DS(ON)} & (at \ V_{GS} \! = \! 10V) & < 24m\Omega \\ R_{DS(ON)} & (at \ V_{GS} \! = \! 4.5V) & < 30m\Omega \\ R_{DS(ON)} & (at \ V_{GS} \! = \! 2.5V) & < 48m\Omega \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum Ratings T _A =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V_{GS}	±12	V			
Continuous Drain Current	T _A =25℃		8.5				
	T _A =70℃	'D	7.1	A			
Pulsed Drain Current C		I _{DM}	60				
Avalanche Current ^C		I _{AS} , I _{AR}	14	A			
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	10	mJ			
	T _A =25℃	P _D	3.1	W			
Power Dissipation ^B	T _A =70℃	L D	2	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C			

Thermal Characteristics							
Parameter	Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s		31	40	€/M		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	59	75	℃/W		
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	16	24	℃/W		



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V	T 55%			1 5	μA		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±12V	T _J =55℃			100	nA		
	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$			1.05	1.45	V		
V _{GS(th)}	On state drain current	$V_{\text{DS}} = V_{\text{GS}} \cdot V_{\text{DS}} = 5V$		0.65 60	1.00	1.40	A		
I _{D(ON)}	On State diami current	$V_{GS}=1.0V, V_{DS}=0.00$ $V_{GS}=1.0V, I_{D}=8.5A$		- 00	17.7	24	- / (
R _{DS(ON)}	Static Drain-Source On-Resistance	VGS-10V, 1D-0.5A	T _J =125℃		28	34	mΩ		
		V _{GS} =4.5V, I _D =8.5A	Ů		19	30	mΩ		
		V_{GS} =2.5V, I_D =5A		24	48	mΩ			
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =8.5A			37		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V		
I _S	Maximum Body-Diode Continuous Current					4	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance				630		pF		
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			75		pF		
C _{rss}	Reverse Transfer Capacitance				50		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.5	3	4.5	Ω		
SWITCHI	NG PARAMETERS								
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =15V, I _D =8.5A			6	7	nC		
Q_{gs}	Gate Source Charge				1.3		nC		
Q_{gd}	Gate Drain Charge				1.8		nC		
t _{D(on)}	Turn-On DelayTime				3		ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.8 Ω , R_{GEN} =3 Ω			2.5		ns		
t _{D(off)}	Turn-Off DelayTime				25		ns		
t _f	Turn-Off Fall Time				4		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =8.5A, dI/dt=100A/μs			8.5		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =8.5A, dI/dt=100A/μs			2.6		nC		

A. The value of $R_{\theta JA}$ is measured with the device mounted on $1 in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.i}=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

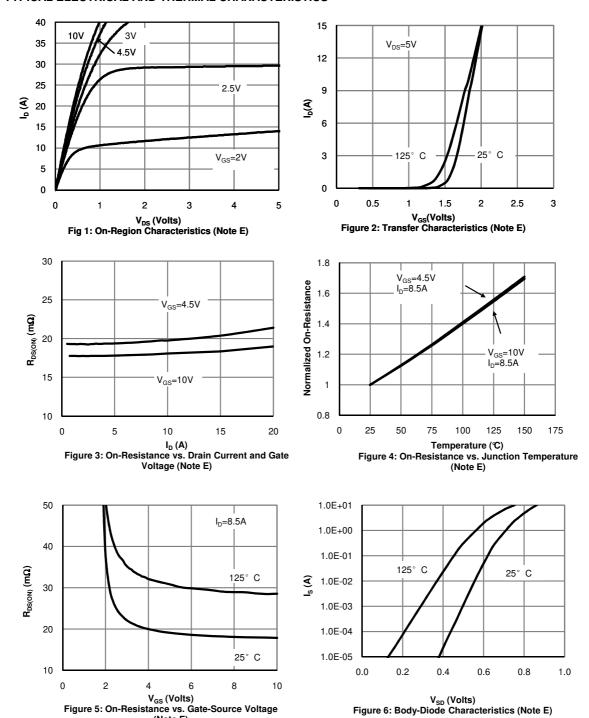
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating.



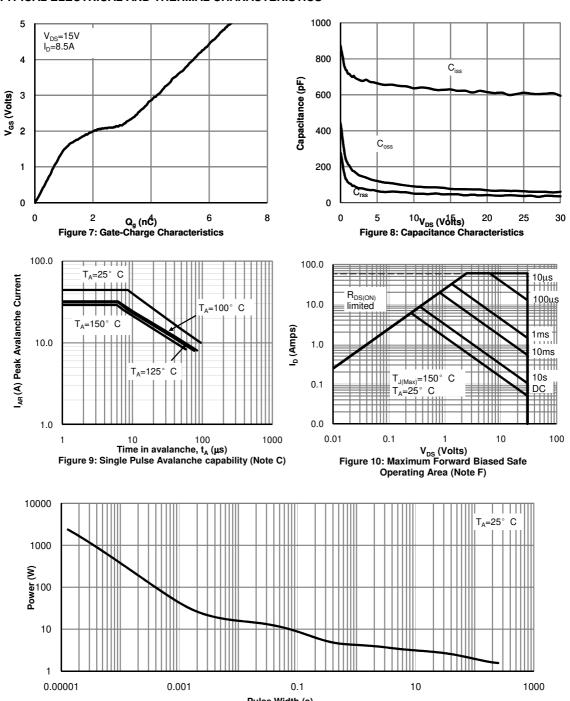
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





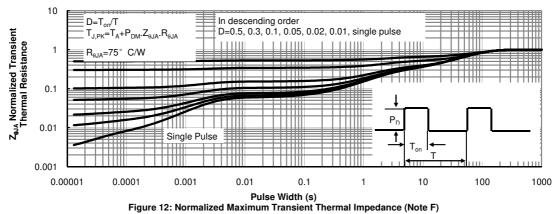
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

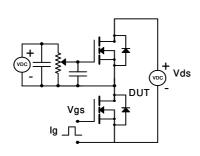


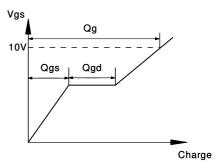
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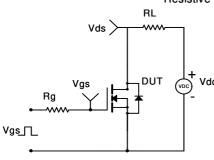


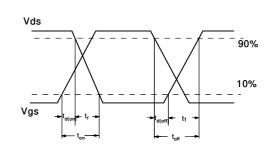
Gate Charge Test Circuit & Waveform



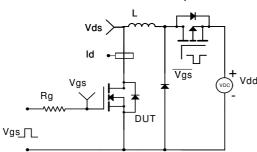


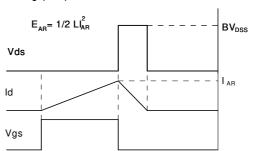
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

